

Notice of References Cited	Application/Control No. 10/549,615	Applicant(s)/Patent Under Reexamination HOSHINO ET AL.	
	Examiner Linh V. Nguyen	Art Unit 2819	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0208145 A1	10-2004	Sim et al.	370/335
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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